

# Search Notes



Application/Control No.

10/004,900

Examiner

Tan Dean D. Nguyen

Applicant(s)/Patent under Reexamination

GRUBER ET AL.

Art Unit

3629

## SEARCHED

Class	Subclass	Date	Examiner
705	1	9/05	20
	6		
	7		
	8		
	9		
	14		
	26		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	9/05	20
PG Pat		
II FOREIGN		
EPO JPO Derwent		
III NPL		
1. Flex1		
2. Flex2		
3. NFlex		